## Shot noise and multiple Andreev re ections in d-wave superconductors

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W e present a theoretical analysis of the shot noise in d-wave/d-wave contacts with arbitrary transparency, including the contribution of multiple Andreev re ections. The multiple charge quanta transferred in these processes are revealed as a huge enhancement of the noise-current ratio at low voltages, which survives for all crystalm isorientations. W e also show how di erent ingredients like non-magnetic impurities or a magnetic eld produce very characteristic hallmarks in the shot noise, which can be used as a further test of the d-wave scenario in superconducting cuprates.

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In the last years the intensive study of the nonequilibrium current uctuations, known as shot noise, has provided a deeper understanding of the electronic transport in m any di erent contexts [1]. The shot noise reveals aspects hidden in the usual conductance m easurem ents like the statistics and charge of the carriers, relevant energy scales or transmission information. In the case of superconducting contacts, the noise has been mainly used for the analysis of the e ective charges transferred in the di erent tunneling processes. This e ective charge can be roughly de ned as the noise-current ratio. A striking example is the recent observation in superconducting atom ic-size contacts of e ective chargesm uch larger than unity attributed to multiple Andreev re ections [2], and in quantitative agreem ent with the theoretical expectations [3]. Unfortunately, the analysis of shot noise has been mainly restricted to conventional superconductors, and only a few theoretical works have recently addressed noise in NIS-junctions with d-wave superconductors [4].

On the other hand, the origin and nature of the high tem perature superconductivity in the cuprates is still. an open problem . D i erent phase-sensitive experiments have provided strong indications that the order param eter in these materials has a dominant  $d_{x^2}$   $v^2$  component [5, 6]. However, these experiments have not de nitively closed the debate about basic questions like the universality of this symmetry or the existence of subdom inant components [7, 8]. In this sense, it is highly desirable to provide new tools which can further test the di erent scenarios. Thus, a natural question is: what can the shot noise teach us in unconventional superconductivity? For instance, the shot noise provides fundam ental information on the charge of the carriers, as it was shown in complex situations like in the fractional quantum Hall e ect [9] or in superconducting point contacts [2]. On the other hand, the shot noise in a junction depends in a di erent way on the interface properties as com pared with the current. In this sense, the study of this quantity can used as a cross-check for the di erent transport theories, and in turn it can be very valuable to solve the lack of consensus in the interpretation of the tunneling

experiments in cuprate junctions [10].

In this paper, we present the st theoretical analysis of the shot noise in d-wave/d-wave SIS junctions of arbitrary transparency. We shall show that the zerofrequency noise, S, may by large exceed the Poisson value 2eI, where I is the current, due to the occurrence of multiple Andreev re ections. In particular, at high transparencies the e ective charge, q, de ned as q = S=2I, exhibits a huge enhancement at low voltages (q=e 1), which survives for all crystal m isorientations. At low transparencies, contrary to the s-wave case, q is not quantized in units of the electron charge due to the averaging over the anisotropic gap. We shall also show that elastic scattering mechanisms like bulk impurities may result in a strong reduction of the e ective charge. Finally, we shall show how the Doppler shift of the Andreev bound states in the presence of a magnetic eld is revealed in the shot noise. All these features are very characteristic of the d-wave symmetry and can be used as additional tests of this scenario in cuprates.

Our goal is to extend the theory of the shot noise to the case of superconducting cuprates. For this purpose, we consider a voltage biased contact, consisting of two  $d_{x^2 \ y^2}$  superconductors separated by a single interface of arbitrary transparency. The order parameter on side i, i = L;R, is rotated by i with respect to the surface normal, and we denote junction type by the relative crystal orientations as d  $_{\rm\scriptscriptstyle L}$  -d  $_{\rm\scriptscriptstyle R}$  . There are several experimental realizations of this system, among which the bicrystal grain-boundary junctions are ideal exam ples [11]. To calculate the noise we use the form alism developed in Ref. [12]. In that work we introduced a formulation of boundary conditions that m in ics interfaces for the quasiclassical theory of superconductivity and that are suitable for arbitrary transparency, and we established the machinery to determ ine the current uctuations in unconventional junctions. Here we consider the case of point-contact-like geom etry and assum e that the voltage drop takes place at the interface. Thus, to compute the noise we rst determ ine self-consistently the local electronic properties of the isolated electrodes.

This includes e ects on the order parameter prole and on the local density of states (DOS) by pair breaking caused both by quasiparticle scattering o the interface and o hom ogeneously distributed in purities in the crystals [13, 14, 15, 16, 17, 18]. Finally, the noise is calculated using the local surface G reen's and solving the appropriate boundary conditions for a point contact, as detailed in Ref. [12].

The noise spectral density S (!) is de ned as

$$S(!) = d(t^{0} t) e^{i!(t^{0} t)} h \hat{I}(t^{0}) \hat{I}(t) + \hat{I}(t) \hat{I}(t^{0})i;$$

where  $\hat{f}(t) = \hat{f}(t)$ ht(t) i are the uctuations in the current. We only consider the zero-frequency lim it at zero tem perature. In the case of a constant bias voltage, V, one can show (see Ref. [12]) that the noise oscillates in time with all the harm onics of the Josephson frequency, i.e. S(t) = $_{m}$  S<sub>m</sub> e<sup>im</sup> (t), where (t) =  $_0$  + (2eV=~)t is the time-dependent superconducting phase di erence. W e shallonly consider the dc noise, denoted from now on as S. Furtherm ore, we assume that the interface conserves the momentum of the quasiclassical trajectories, which allows us to write the noise as a sum over independent trajectory contributions: S = =2  $\frac{1}{2}$  $\int_{-2}^{2} d\hat{p} S(\hat{p}) \cos(\hat{p})$ , where  $\hat{p}$  denes the Fermi surface position. For the angular dependence of the transmission coe cient we use the expression D ( $\hat{p}$ ) =  $D \cos^2(\beta) = [1 \quad D \sin^2(\beta)]$ , resulting from a -like potential. Here D is the transm ission for the trajectory perpendicular to the interface. In the tunneling regime one can easily dem onstrate that the zero-frequency noise reaches the Poisson value, i.e. S = 2eI. Thus, in this limit the noise does not contain new inform ation as com pared with the current. For this reason, we shall investigate the case of not too low interface transparency, D 0:1, in which the multiple Andreev reections (MAR) play a fundam ental role in the transport [19, 20].

Let us start by analyzing the case of a symmetric  $d_0$  $d_0\,$  junction in the clean limit. In this case, the order param eter is constant up to the surface, and there are no bound states for any trajectory. The noise-voltage characteristics for a single trajectory, S (2), coincide with those of isotropic s-w ave superconductors [3], and can be seen in Fig 1(a). As a consequence of the occurrence of MARs, the trajectory-resolved shot noise exhibits the following remarkable features: (i) the presence of a pronounced subharm onic gap structure (SGS) at voltages eV = 2 ( $\hat{p}$ )=n, (ii) the noise greatly exceeds the Poisson value 2eI in the subgap region, as can be seen in Fig 1(b), and (iii) in the tunneling regime the e ective charge is quantized in units of the electron charge. This last feature, illustrated in the inset of Fig 1(b), was used to suggest that the noise provides a way of measuring the charge of individual MARs in swave superconductors [3]. Indeed, as mentioned in the introduction, these noise-voltage characteristics have been quantitatively con med in the context of superconducting atom ic contacts [2]. The natural questions now are: do these features survive after doing the average over the di erent directions in the Ferm i surface? Can we still identify the charge of individual MARs in a d-wave junction?. The answers to these questions can be seen in Fig. 1 (c-d). First of all, notice that the SGS is still visible, but it is more rounded than in the s-wave case. It is worth remarking that it is the bulk maximum gap what is revealed in the SGS.Notice also that the elective charge does not show any sign of quantization even at low transparencies (see inset of Fig. 1 (d)). This is due to the fact

that di erent MARs contribute sin ultaneously for di erent trajectories, and then the discreteness of q is washed out. A nyway, the dom inant contribution of MAR at high transm ission is still manifested as a huge enhancement of the elective charge at low bias (q e).

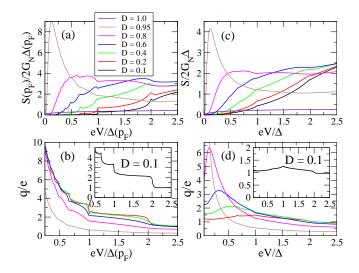


FIG.1:  $d_0 - d_0$  contact in the clean case: (a) Angle-resolved shot noise as a function of the voltage in units of the trajectory gap for di erent transmissions. G<sub>N</sub> is the normal state conductance. (b) Angle-resolved e ective charge, q = S=2I. (c) Angle-averaged shot noise. The voltage is normalized by the maximum gap . (d) Angle-averaged e ective charge.

Let us now consider the case of a d  $_{=4}$ -d  $_{=4}$  junction. In this case, assuming specular quasiparticle scattering at the interface, an Andreev bound state forms at zero energy for every trajectory [21]. This implies that the surface acts as a pair-breaker [13, 14] and the gap is depressed in the vicinity of the interface, vanishing exactly at the barrier. This order-parameter proble induces not only the appearance of bound states at zero energy, but also at the gap edges, as can be seen in the inset of F ig. 2 (b). As a consequence of this local density of states the noise exhibits a pronounced SG S due to resonant tunneling through the bound states (see Fig. 2 (a)). As in the

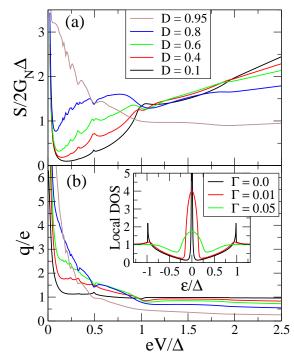


FIG.2: d  $_{=4}$ -d  $_{=4}$  contact in the clean case: (a) Shot noise as a function of voltage for di erent transm issions. (b) Effective charge vs voltage. The curves were computed using a small inelastic broadening (0.003). Inset: local DOS at the interface for a  $45^\circ$  m isorientation for di erent values of the bulk-impurity scattering rate (Born scatterers), measured in units of 2 $T_{\rm C}$ , where  $T_{\rm C}$  is the critical temperature in the clean case. is the maximum bulk gap for the clean superconductor.

case of the current, see R ef. [20], there is an even-odd effect in the SGS, in the sense that the even (eV = =n)structures are m ore pronounced. Its origin can be understood as follows. In this geometry there are two types of MARs which dom in ate the transport: (a) those which connect the bound states with the gap edges and (b) the usual ones connecting the gap edges. The st ones give rise to the SGS at eV = =n, while the second ones contribute to the whole series  $eV = 2 = n \cdot H$  ow ever, the bound states at the gap edges do not appear for every trajectory, which weakens the SGS due to these processes. On the other hand, as we show in Fig. 2(b) the e ective charge is not even quantized at low transparencies, again due to the average over the di erent trajectories. How ever, at high transparencies the dom inant contribution of the MARs give rise to a huge enhancement of the e ective charge at low bias. This is a robust feature which survives for all crystalm isorientations, and it is an unambiguous signature of the fact that the MARs control the low voltage transport. Indeed, this pronounced increase of the noise-current ratio at low bias has been recently observed in symmetric bicrystal YBCO Josephson junction [22] in, to our know ledge, the st experimental analysis of the shot noise in cuprate Josephson junctions. In this experiment a mean transparency of D 0:01 was estimated, but in our opinion this enhancement is due to MARs in high transparent conduction channels, probably due to the presence of pinholes like in the conventional SIS tunnel junctions of D ieleman et al. [23].

In d-wave superconductors the order parameter is very sensitive to scattering from nonmagnetic impurities and surface roughness. In particular, it is known that these elastic scattering mechanism sprovide an intrinsic broadening for the zero-energy bound states [17, 18]. For the case of Born scatterers this broadening is / ,where = 1=2 is the e ective pair-breaking param eter locally at the surface. This is illustrated in the inset of Fig. 2 (b) for the case of bulk in purities. The interesting question now is: what is the signature of impurities in the shot noise of a d-wave junction? In Fig. 3 we show the shot noise and e ective charge for a  $d_{=4}$  -  $d_{=4}$  junction for di erent values of the bulk-in purity scattering rate. As the scattering rate increases, there are two major effects that one should notice: (i) the disappearance of the SGS in the noise, and (ii) a reduction of the e ective charge, specially pronounced at low voltages. Both features can be understood as follows: the increase of density of states in the gap region enhances the probability of single-quasiparticle processes, producing the subsequent reduction of the probability of the Andreev processes, which in turn leads to both the suppression of the SGS and the reduction of the e ective charge.

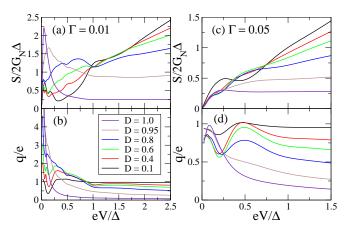


FIG .3: Shot noise and e ective charge as a function of voltage for a d  $_{=4}$ -d  $_{=4}$  contact for two values of the bulk-in purity scattering rate .

Fogelstrom et al. [15] have shown that the Andreev bound states should split in the presence of a magnetic eld perpendicular to the ab-plane. This splitting results in a splitting of the zero bias conductance peak observed in tunnel junctions [24]. It is then interesting to analyze what is the signature of this time reversal sym metry breaking in the shot noise. Let us consider a magnetic eld perpendicular to the ab-plane, H = H 2. A s m entioned above, this eld leads to a D oppler shift in the

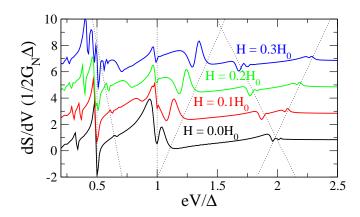


FIG.4: D i erential shot noise of a clean d  $_{=4}$  d  $_{=4}$  junction with D = 0.2 and di erent values of the magnetic eld. The curves has been vertically displaced for clarity and dotted lines have been added to guide the eye.

continuum excitations given by v<sub>f</sub> p, where the condensate momentum is  $p_s =$ (e=c)A(x), with A the self-consistently determ ined vector potential [15]. This means that the Andreev bound states are shifted to an energy which, in the lim it of a large ratio = 0, can be estimated to be  $_{b}(\hat{p}) = (e=c)v_{f}H \sin \hat{p}$ , being the ab-plane penetration depth. W e shall use a natural eld scale set by a screening current of order the bulk critical current,  $H_0 = c = ev_f$ , which is of the order of a Tesla [15]. The screening currents ow parallel to the interface and in opposite directions in both electrodes, which m eans that the trajectory resolved DOS of the left and right superconductors are shifted by  $2_{\rm b}$  (2) relative to each other. As explained in Ref. [20], this shift modi es the threshold voltages of MARs starting and ending in di erent electrodes, leading to the splitting of the peaks with an odd order n in the SGS.On the contrary, since the magnetic eld produces a rigid shift of the spectrum, the threshold voltages of those MARs starting and ending in the same electrode are not modi ed. This means that the positions of the structures with an even order n in the SGS remain unchanged. This is illustrated in Fig. 4 where we show the di erential shot noise, dS = dV, for a d  $_{=4}$ -d  $_{=4}$  junction with transm ission D = 0.2 for di erent values of the magnetic eld. Starting at large voltages, the structure at 2 splits with applied eld. A round eV = there is a maximum at eV = , una ected by the applied eld, as well as a eld-shift of the peak just above . The eld dependence of the differential noise is most clearly resolved at larger biases, eV =2, as the marks of the various processes begin to overlap at sm all bias. The e ect of the D oppler shift on the SGS of the noise is only prominent in junctions with a sizable misorientation. For junctions close to the  $d_0 - d_0$  case, the main contribution to the SG S com es from trajectories close to perpendicular incidence, i.e. with

 $\sin \hat{p}$  0 and thus having a vanishing D oppler shift.

In sum m ary, we have presented a theory of shot noise in d-wave/d-wave contacts with arbitrary transparency. We have shown that in the MAR regime these nonequilibrium current uctuations exhibit very peculiar features like subharm onic gap structure, super-Poissonian noise (S 2eI), reduction of the elective charge q by im purities and the splitting of the SGS in a magnetic eld. All these features are unique ingerprints of the d-wave scenario, and we hope that our analysis will trigger o experimental study of shot noise in cuprate junctions.

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